





Workshop on Pico-Second Timing Detectors for Physics and Medical Applications
Torino
16-18 May 2018

Low-Gain Avalanche Diodes for Precision Timing in the CMS Endcap

V. Sola on behalf of the CMS Collaboration

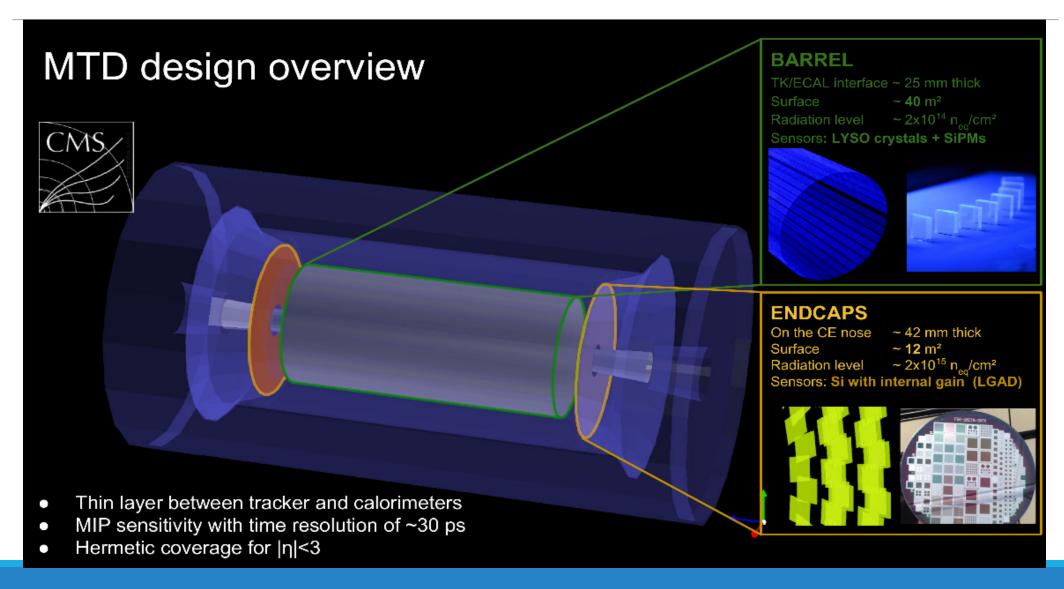




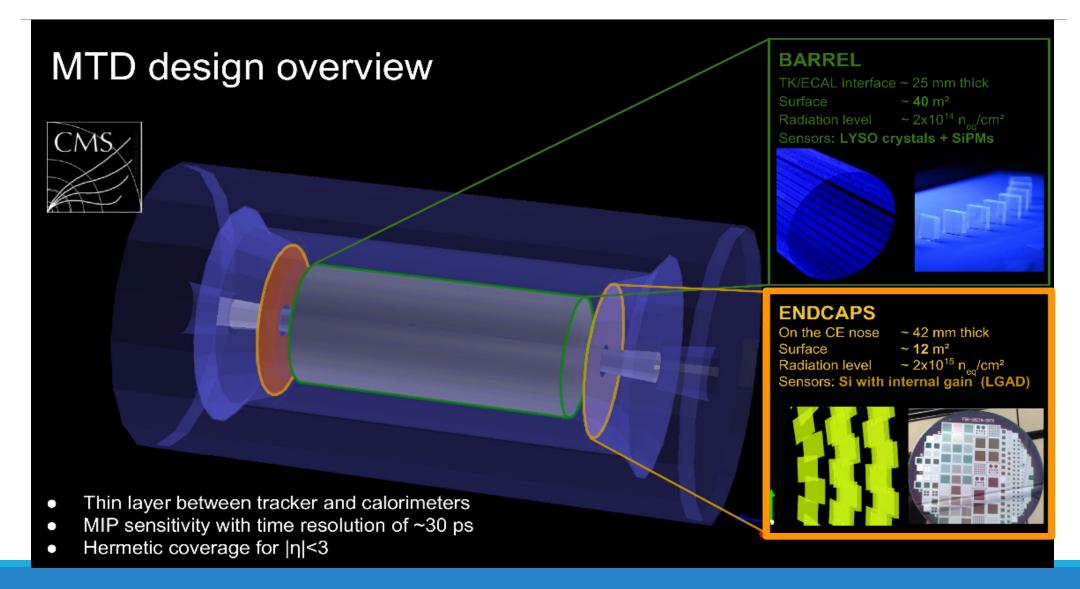
OUTLINE

- Endcap Timing Layer overview
- **Low-Gain Avalanche Diodes for large area detectors**
 - R&D on the production processes
 - Improvement on the radiation tolerance
- Front-End design for fast signals
 - ToT vs CFD
 - Effects of radiation on signal shape
- Clock distribution

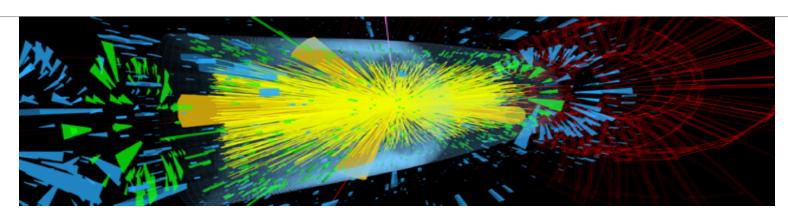
MIP Timing Detector for CMS Phase II Upgrade



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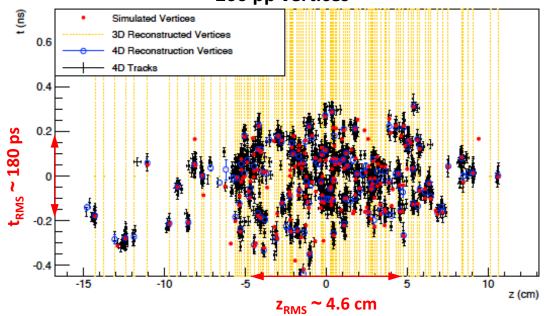


Why an Hermetic MTD?



Simulation of a VBF H $\rightarrow \tau\tau$ in 200 pile-up pp collisions





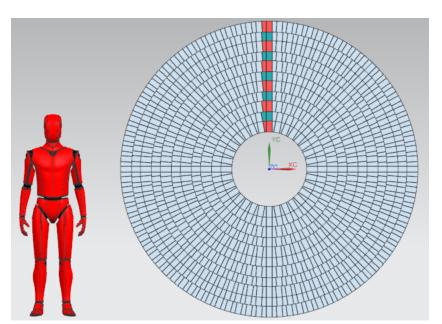
The addition of track-time information with 30 ps resolution reduces the wrong track-to-vertex associations to a level comparable to the current LHC running conditions

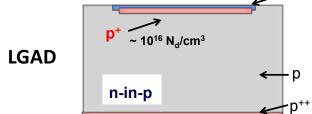
☞ Vertex merging is reduced from 15% in space to 1% in space-time

Endcap Timing Layer - ETL

	Barrel LYSO+SiPM	Endcap LGAD
Coverage	$ \eta < 1.5$	$1.5 < \eta < 3.0$
Surface Area	\sim 40 m 2	$\sim 12~\text{m}^2$
Power Budget	\sim 0.5 kW/m ²	\sim 1.8 kW/ m^2
Radiation Dose	$\leq 2e14 \text{ neq/cm}^2$	\leq 2e15 neq/cm ²
Installation Date	2022	2024

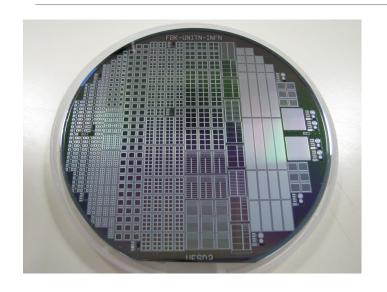
- > Low-Gain Avalanche Diodes (LGAD) operated with gain $\mathcal{O}(10)$ for sufficient S/N
- > Small pixel area to cope with the high occupancy at high η values
- > High radiation tolerance up to $\sim 3.10^{15} \, n_{eq}/cm^2$
- ➤ Installation date allows for some R&D

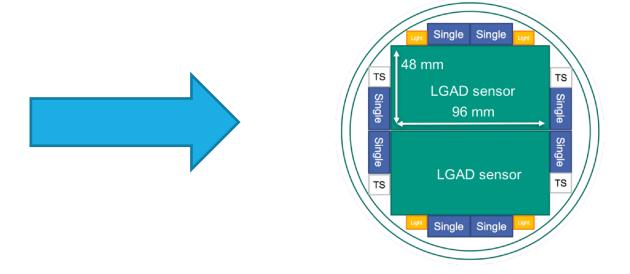


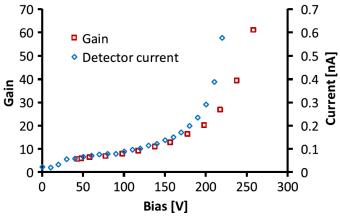


- Overlapping disk structure for hermetic coverage with single LGAD layer
 95% coverage, driven by inactive region between pixels
- > 1x3 mm² LGAD pixels, read out in groups of 3 for $|\eta|$ < 2.1, where occupancy allows
- > 1.8 M channels at read-out level

LGAD from mm² to m²



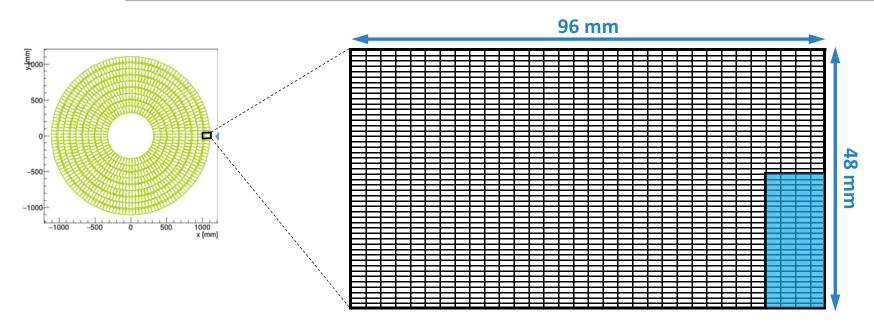




[N. Cartiglia et al., NIM A 850 (2017) 83-88]

- > LGAD are routinely produced by 3 vendors (CNM, FBK, HPK)
- > The time resolution of thin (\sim 50 μ m) LGAD is 30-35 ps
- The low gain allows segmenting and keeping the shot noise small, below the electronic noise, since the dark current is low
- > A very clean production process is necessary to keep the detector noise low, as the sensor dark current is multiplied by the gain mechanism

Sensor Strategy



➤ The 3 vendors plan to produce first demonstrators of big LGAD sensors in 2018

First test sensor is made of 24x4 pads - 1/16 of the full ETL sensor

→ 1 read-out chip size

⇒ First time that big sensors with internal gain are produced

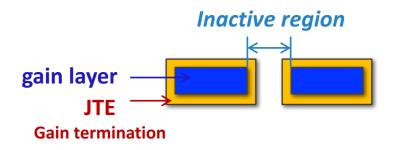
Final Goal:

- > Produce 2624 sensors → **1400 6-inch wafers**
- Each sensor is 48x96 mm² with 1536 pads, each pad is 1x3 mm²

Crucial Aspects:

- > Sensor size
- > Fill factor
- > Radiation tolerance

Fill Factor Status



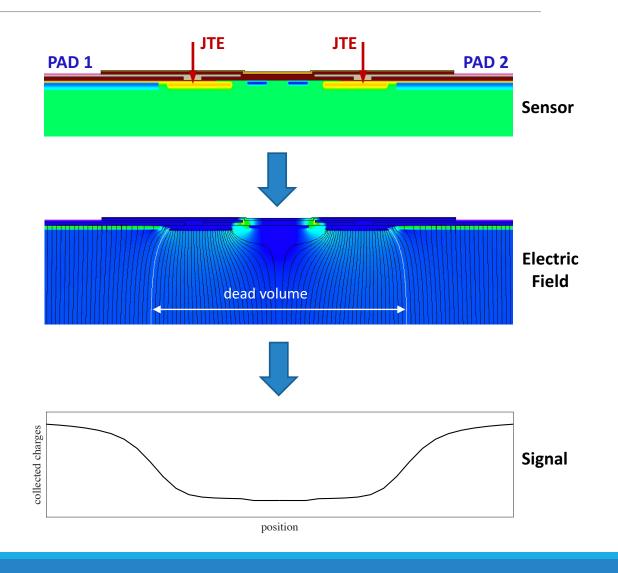
Fill Factor = Active Area / Geometrical Area

The fill factor is mainly determined by the inactive gap between sensors

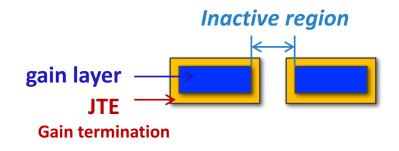
Current measured gap size:

- \sim 70 μm for CNM
- \sim 70 μ m for FBK
- \sim 100 μ m for HPK

 $70 \mu m$ gap corresponds to a 91% fill factor



Fill Factor Plans



Fill Factor = Active Area / Geometrical Area

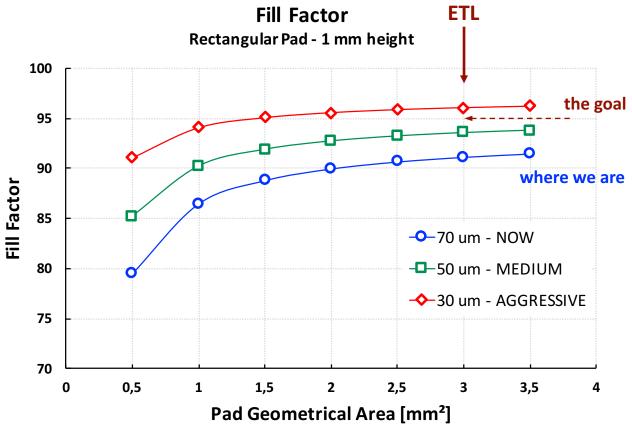
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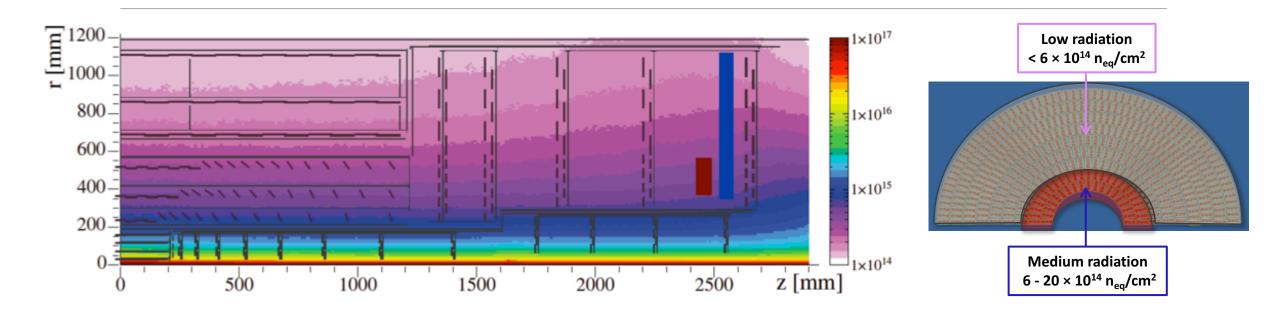
70 μm gap corresponds to a 91% fill factor

 \rightarrow 30 μ m gap corresponds to 96% fill factor CNM, FBK, HPK are working towards this result



10

Expected Radiation for ETL Life Time



LGAD reach 35 ps time resolution for fluences up to 5 - $6 \times 10^{14} \, n_{eq}/cm^2$

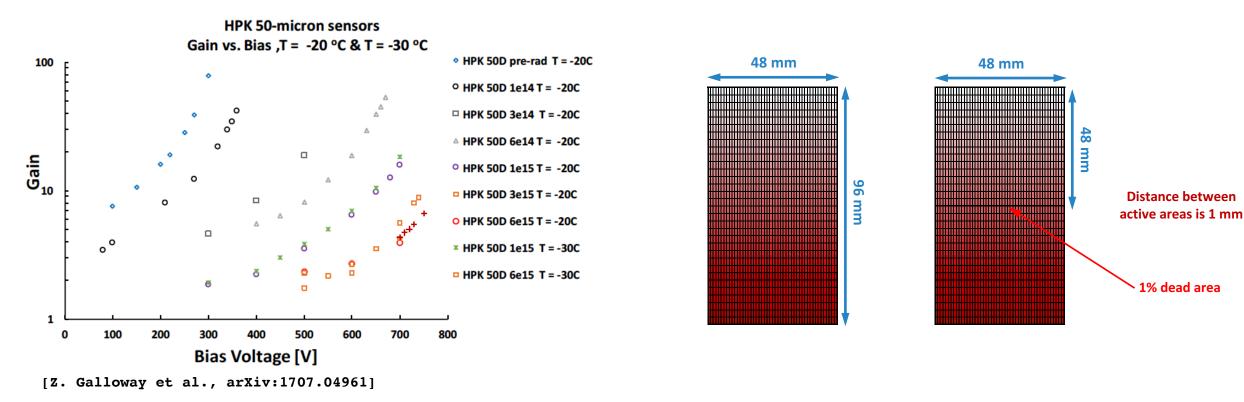
Low radiation: radius 50 - 130 cm \rightarrow 4.8 m², \sim 90%

Medium radiation: radius 30 - 50 cm \rightarrow 0.5 m², \sim 10%

- ⇒ LGAD guarantee unchanged running conditions for > 90% of the ETL coverage
- > For the remaining 10%, higher bias values will compensate for the gain reduction
- > Carbon doped gain layer mitigates the Boron deactivation inside the gain layer volume

Radiation Effects on Boron-Doped LGAD

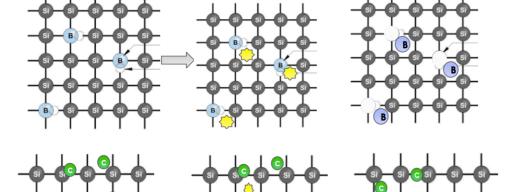
- \rightarrow Irradiation decreases the gain layer active doping \rightarrow less gain
- \rightarrow Increase bias to compensate gain loss \rightarrow recover good time resolution



> Splitting the sensors in 2 parts mitigates the gain reduction due to irradiation but reduces the fill factor

Radiation Effects on Boron+Carbon UFSD

Adding Carbon to the Boron implant halves the reduction of the gain layer doping due to irradiation



Boron

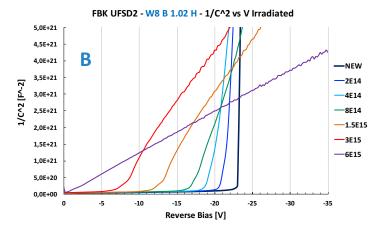
Radiation creates interstitial defects that inactivate the Boron

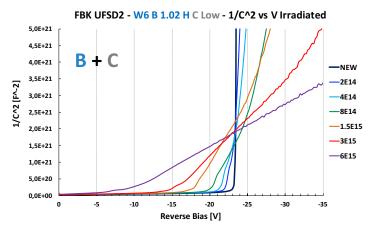
Carbon

Interstitial defects filled with Carbon instead of with Boron and Gallium

- > SIMS measurements confirm this model: pre- and post-irradiated sensors have exactly the same Boron density in the gain layer region, however after irradiation, the Boron is not active any longer
 - → Controlled annealing to re-activate the gain layer under study

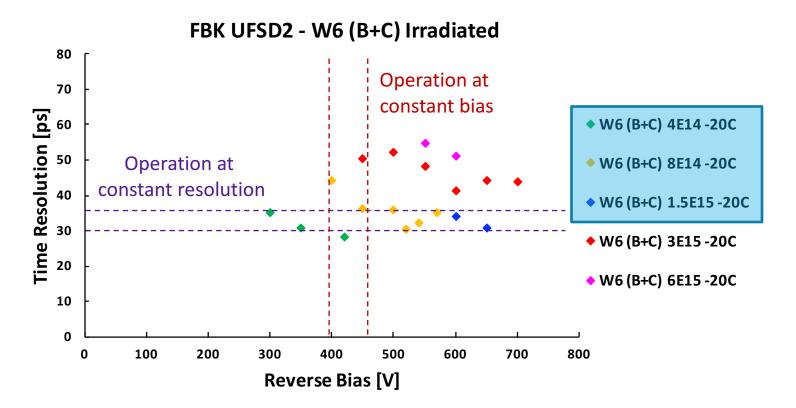
1/C² vs V_{bias} give information on the doping density inside the silicon volume





Time Resolution with Carbon

CMS goal for silicon Endcap Timing Layer Time resolution between 30-35 ps unchanged till the end of lifetime $(4000 \text{ fb}^{-1} - 1E15 \text{ n}_{eq}/\text{cm}^2)$



Possible to reach our goal with Carbonated LGAD

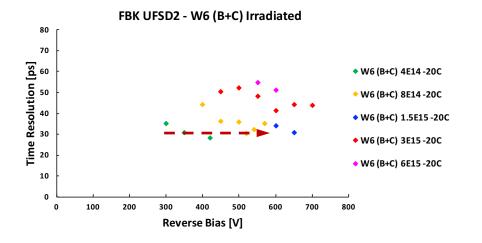
Plans for Sensor R&D Productions

Bias voltage difference from beginning- to end-of-lifetime detector to keep time resolution ~ 30-35 ps

300 V when NEW \rightarrow 600 V @ 4000fb⁻¹ $\Rightarrow \Delta V = 300 \text{ V}$ along the full detector lifetime

Plans to further improve the radiation resistance in next FBK UFSD3 production

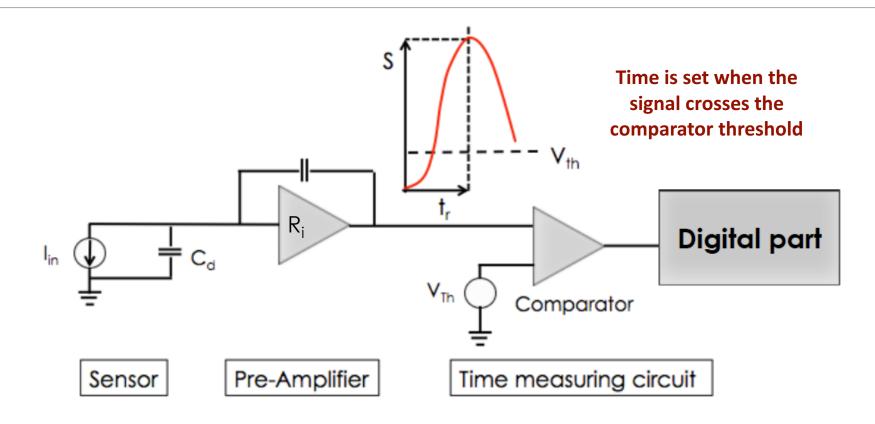
- > Carbon dose optimisation
- > Boron diffusion temperature optimisation
- Process sequence optimisation



The goal is to further reduce the ΔV along the full detector lifetime \Longrightarrow The dream would be to reach $\Delta V = 0V$

CMS foresees 3 productions from 3 different vendors (CNM, FBK, HPK) to define the final ETL sensor design by the end of 2020

An Overview of the Front-End Electronics

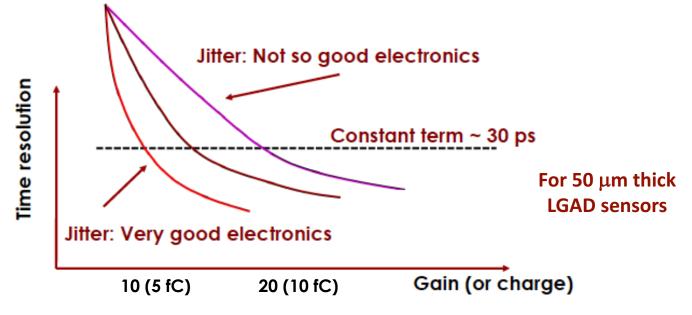


- > The analogue part plays a key role in the time resolution
- > A front-end with very low input impedance that works in full current mode better exploits the fast signals from LGAD

$$R_i \times C_d < Signal Rise Time \sim 300-400 ps$$

Contributions to the Time Resolution

$$\sigma_t^2 = \left(\frac{N}{dV/dt}\right)^2 + \sigma_{non-uniform\ charge\ deposition}^2$$



Two components determine the time resolution:

- > Non-uniform charge deposition \rightarrow \sim constant term 25-30 ps
- >> Jitter contribution = N / (dV/dt) ~ 1 / Gain (driven by the electronics)

Goal for the front-end chip jitter ~ 20 ps

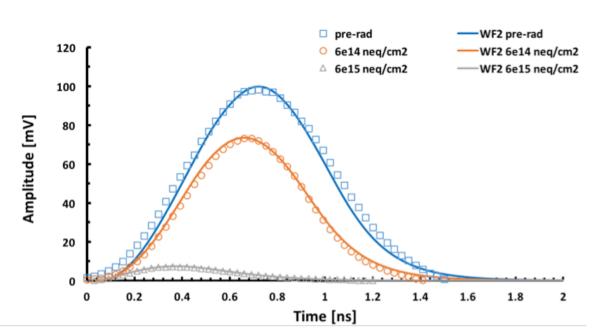
Evolution of the Signal with Fluence

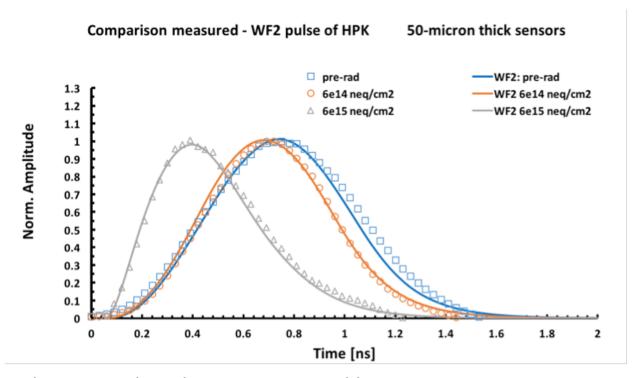
With irradiation the LGAD signal becomes faster, shorter and smaller

 $Q: 10 fC \rightarrow 2 fC$

Rise time : 400 ps → **200 ps**

Comparison measured - WF2 pulse of HPK 50-micron thick sensors





The signal tails change dramatically with irradiation, ToT might not work without constant calibration

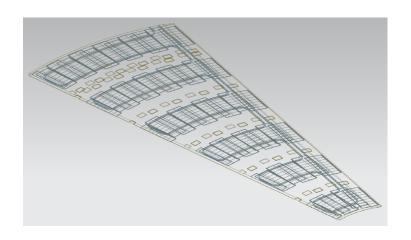
Solution Constant Fraction Discriminator is the safest option

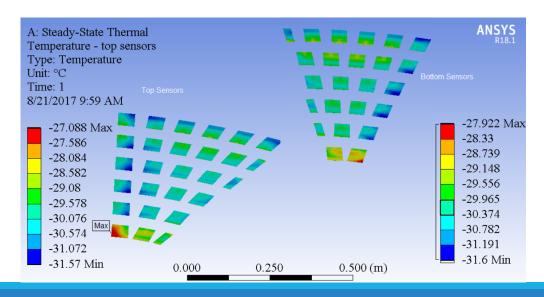
Mechanics and Cooling

- > Endcap Timing Layer will be placed in an independent, thermally isolated volume on the nose of the Endcap Calorimeter detector, at a distance of about 3 m from the interaction point
- > ETL modules will be mounted in rings on flat aluminium support structures, ensuring a continuous coverage in ϕ
- ➤ The power dissipated by the modules will be removed by a network of low-mass cooling pipes fed by a CO₂ cooling system separated from the other CMS detectors
- > The heat generated on the modules will be transferred via the aluminium support to the CO₂ cooling pipes, keeping the silicon sensors at an operating temperature below -27° C

> The cooling system allows for a power consumption of the read-out electronics of 100 mW/cm² for the read-out chip

and ~ 3 mW per channel





Clock Distribution

- ➤ A common R&D project for CMS Phase-II upgrades underway for a high precision clock distribution targeting 10 15 ps time resolution
- > Two options kept open for timing detector:
 - → LHC clock to each module encoded in IpGBT control links (no additional fibres needed)
 - → Dedicated clock fibres + fan-out chip in case desired precision cannot be otherwise achieved
- > Slow drifts or other low-frequency instabilities can be monitored and calibrated out with minimum bias data in-situ
- ➤ Also the ASIC design has to focus on ensuring that the clock can be distributed over a large area without introducing a jitter that would spoil the precision of the measurement

A CERN working group was formed between PH/ESE group and experiments to develop a High Precision Timing Distribution for High-Luminosity LHC (2024)

Progress track is available at https://indico.cern.ch/category/2388/

SUMMARY

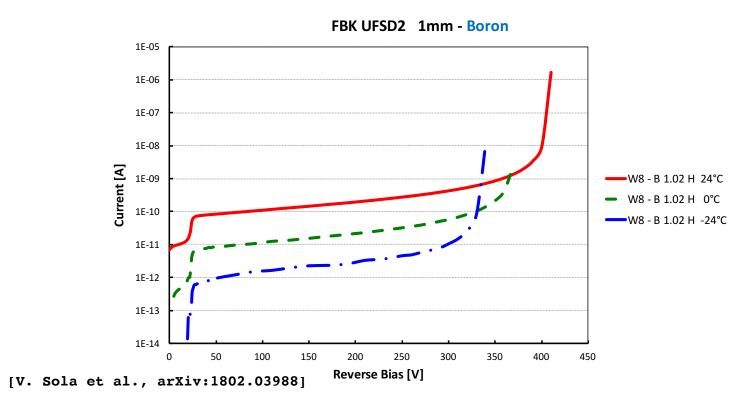
- > First production of UFSD sensors with ETL geometry
 - ▷ 4x24 pad sensors from CNM, FBK, HPK in production
- > Radiation tolerance
 - Carbon inside the gain implant halves radiation effect
 - Possible to keep time resolution at 30-35 ps up to the total fluence expected for 4000 fb⁻¹
- > Front-End Electronics design crucial to maintain time resolution ~ 30 ps
 - Avoiding signal integration fully exploits the fast signals from LGAD
 - Constant Fraction Discriminator is the best choice to read out signals from irradiated LGAD
- > Clock distribution is a key aspect for precise timing measurements
 - \Rightarrow 12 m² silicon detector for precise timing of MIPs is becoming real

ACKNOWLEDGEMENTS

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- → Horizon 2020, grant INFRAIA
- ▷ AIDA-2020, grant agreement no. 654168
- □ U.S. Department of Energy, grant no. DE-SC0010107
- ▷ Fermilab LDRD, grant L2017.027
- ⊳ RD50, CERN

IV Curves - Temperature Dependence



- ▶ Leakage current scales with the temperature (expected a factor 2 for every 7°C)
- Expected a gain inversely proportional to the temperature
- Internal Breakdown shift towards lower voltage due to the temperature decreasing

 $\Delta T = 48^{\circ}C \rightarrow Current(24^{\circ}C) / Current(-24^{\circ}C) \sim 100 \rightarrow Result expected$

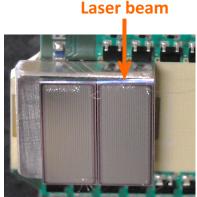
Intra-Strip Inactive Region



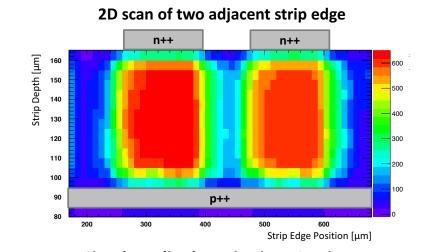
Edge TCT measurement to investigate the intra-structure inactive region

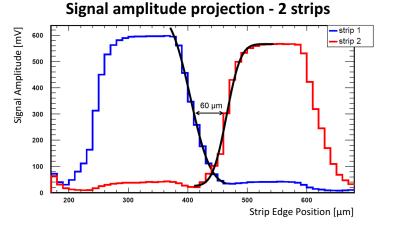
Pico-second IR laser at 1064 nm Laser spot diameter \sim 10 μ m Multistage readout board by Pilsen University Oscilloscope Lecroy 640Zi Room temperature

eTCT scan on 2 adiacent strip W8 V_{hias} = 230 V

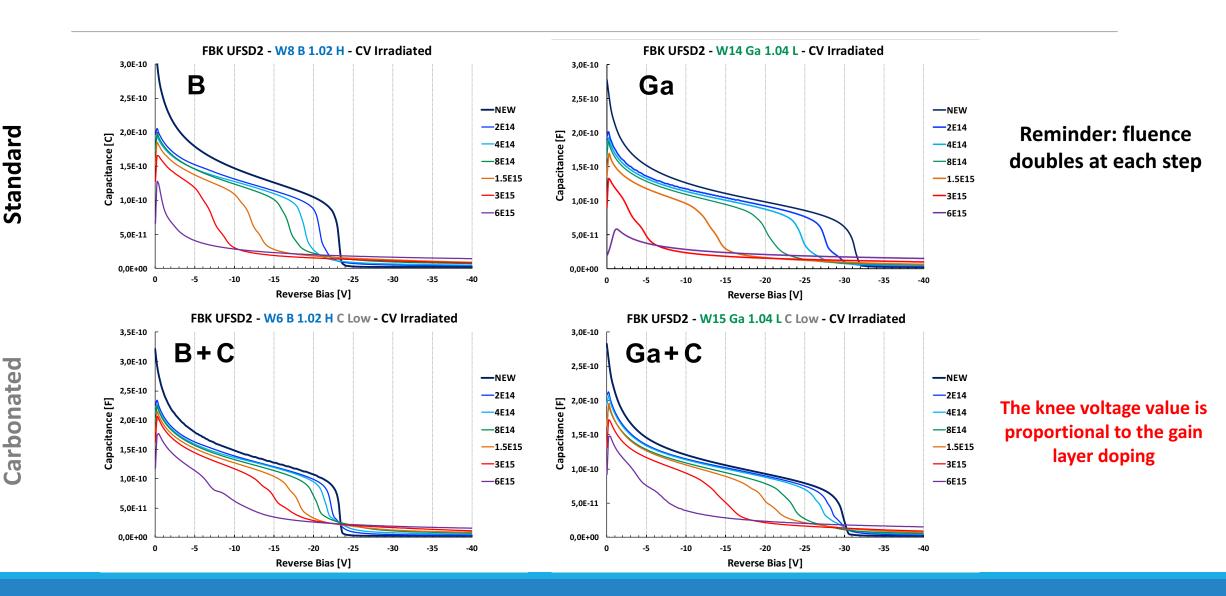


→ The inactive region between two adjacent strips has been measured to be ~ 60 μm





CV Measurements on Irradiated Sensors

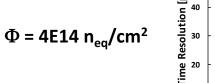


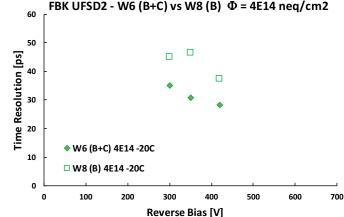
Time Resolution with and without Carbon

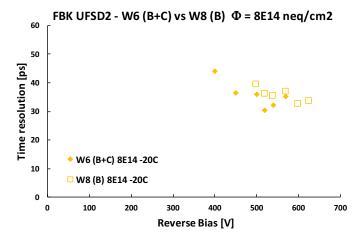


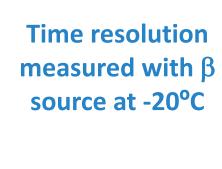
W6 - B+C

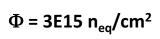
□ W8 - B

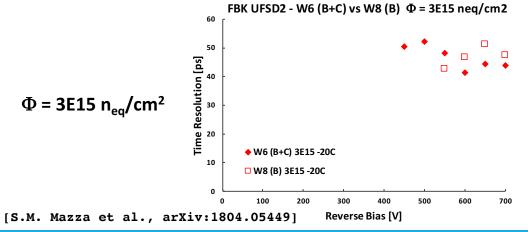


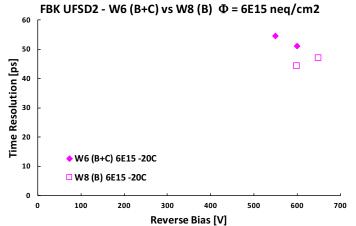












 Φ = 6E15 n_{eq}/cm²

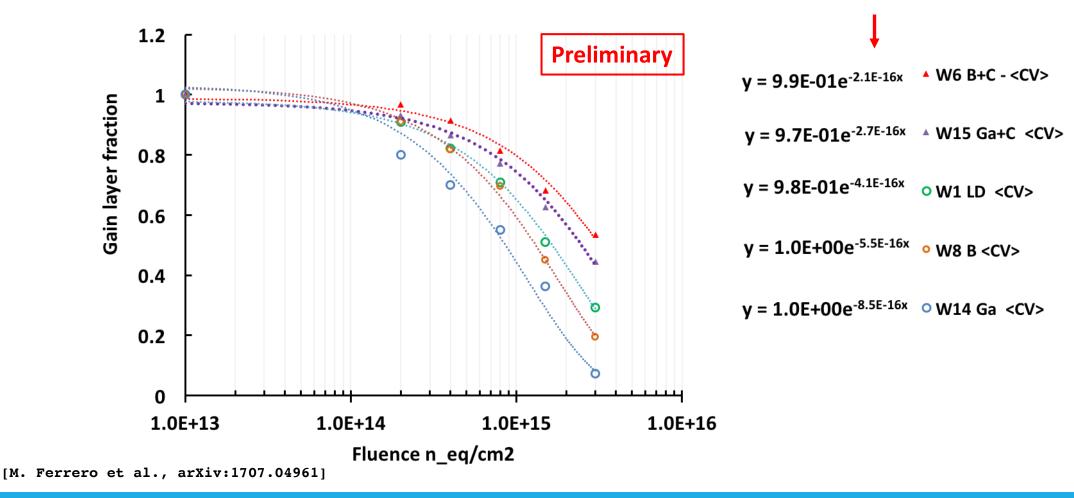
 Φ = 8E14 n_{eq}/cm²

$|N_{\rm A} = N_{\rm A,0} - N_{\rm c} \cdot (1 - \exp(-c \cdot \Phi_{\rm eq}))|$

Acceptor Removal Coefficient $dN_A = -\sum_i c_i \cdot N_A d\Phi$, $c = \sum_i c_i$ ([0],[C],[B])

$$dN_A = -\sum_i c_i \cdot N_A d\Phi \quad , \quad c = \sum_i c_i([O], [C], [B])$$

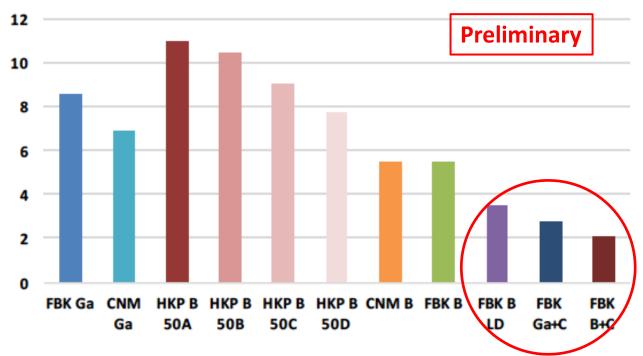
From the fraction of gain layer surviving the radiation, it is possible to extract the acceptor removal coefficient c



Acceptor Removal Coefficient Distribution

HPK data courtesy of G. Kramberger

Acceptor removal c coefficient



- Carbonated sensors have a factor ~ 3 better acceptor removal coefficient
- ► Among not carbonated sensors, low diffusion Boron has the better response to irradiation
- → Will be Boron LD + Carbon the most rad-hard option?